

Notice of References Cited

Application/Control No.

09/995,378

Applicant(s)/Patent Under
Reexamination
OHNO, TOMOYUKI

Examiner

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Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0115600	06-2003	TANAKA, YASUSHI	725/42
*	B	US-2006/0294544	12-2006	Nishina et al.	725/039
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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